Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/765,311	WENDELL ET AL.	
Examiner	Art Unit	
Hiep Nguyen	2816	

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED					
Subclass	Date	Examiner			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST	08.03.05	Mn	
Fee alladiment	08.04.05	Mn	
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